



64K (8K x 8) CMOS EPROM

FEATURES

- High speed performance
 - 120 ns access time available
- CMOS Technology for low power consumption
 - 20 mA Active current
 - 100 μ A Standby current
- Factory programming available
- Auto-insertion-compatible plastic packages
- Auto ID aids automated programming
- Separate chip enable and output enable controls
- High speed "express" programming algorithm
- Organized 8K x 8: JEDEC standard pinouts
 - 28-pin Dual-in-line package
 - 32-pin Chip carrier (leadless or plastic)
 - 28-pin SOIC package
 - 28-pin TSOP package
 - Tape and reel
- Available for the following temperature ranges:
 - Commercial: 0°C to 70°C
 - Industrial: -40°C to 85°C
 - Automotive: -40°C to 125°C

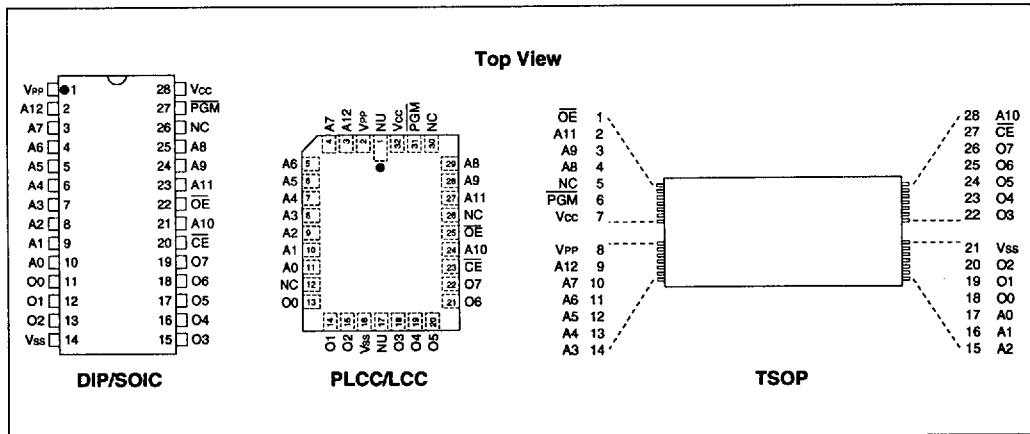
DESCRIPTION

The Microchip Technology Inc. 27C64 is a CMOS 64K bit (electrically) Programmable Read Only Memory. The device is organized as 8K words by 8 bits (8K bytes). Accessing individual bytes from an address transition or from power-up (chip enable pin going low) is accomplished in less than 120 ns. CMOS design and processing enables this part to be used in systems where reduced power consumption and high reliability are requirements.

A complete family of packages is offered to provide the most flexibility in applications. For surface mount applications, PLCC, SOIC, or TSOP packaging is available. Tape and reel packaging is also available for PLCC or SOIC packages. UV erasable versions are also available.



PIN CONFIGURATIONS



PIN FUNCTION TABLE	
Name	Function
A0 - A12	Address Inputs
CE	Chip Enable
OE	Output Enable
PGM	Program Enable
VPP	Programming Voltage
O0 - O7	Data Output
Vcc	+5V Power Supply
Vss	Ground
NC	No Connection; No Internal Connections
NJ	Not Used; No External Connection Is Allowed

ELECTRICAL CHARACTERISTICS

Maximum Ratings*

Vcc and input voltages w.r.t. Vss -0.6V to +7.25V
VPP voltage w.r.t. Vss during programming -0.6V to +14V
Voltage on A9 w.r.t. Vss -0.6V to +13.5V
Output voltage w.r.t. Vss -0.6V to Vcc +1.0V
Storage temperature -65°C to 150°C
Ambient temp. with power applied -65°C to 125°C

*Notice: Stresses above those listed under "Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operation listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

READ OPERATION DC Characteristics		Vcc = +5V ±10%					
		Commercial:		Tamb = 0°C to 70°C			
		Industrial:		Tamb = -40°C to 85°C			
		Extended (Automotive):		Tamb = -40°C to 125°C			
Parameter	Part*	Status	Symbol	Min	Max	Units	Conditions
Input Voltages	all	Logic "1" Logic "0"	V _{IH} V _{IL}	2.0 -0.5	Vcc+1 0.8	V V	
Input Leakage	all	—	I _I	-10	10	µA	V _{IN} = 0 to Vcc
Output Voltages	all	Logic "1" Logic "0"	V _{OH} V _{OL}	2.4	0.45	V V	I _{OH} = -400 µA I _{OL} = 2.1 mA
Output Leakage	all	—	I _{LO}	-10	10	µA	V _{OUT} = 0V to Vcc
Input Capacitance	all	—	C _{IN}	—	6	pF	V _{IN} = 0V; Tamb = 25°C; f = 1 MHz
Output Capacitance	all	—	C _{OUT}	—	12	pF	V _{OUT} = 0V; Tamb = 25°C; f = 1 MHz
Power Supply Current, Active	C I, E	TTL input TTL input	I _{CC1} I _{CC2}	— —	20 25	mA mA	Vcc = 5.5V; VPP = Vcc; f = 1 MHz; OE = CE = V _{IL} ; I _{out} = 0 mA; V _{IL} = -0.1 to 0.8V; V _{IH} = 2.0 to Vcc; Note 1
Power Supply Current, Standby	C I, E all	TTL input TTL input CMOS input	I _{CC(S)} — —	— — —	2 3 100	mA mA µA	CE = Vcc ±0.2V
I _{PP} Read Current	all	Read Mode	I _{PP}	—	100	µA	VPP = 5.5V
VPP Read Voltage	all	Read Mode	VPP	Vcc-0.7	Vcc	V	Note 2

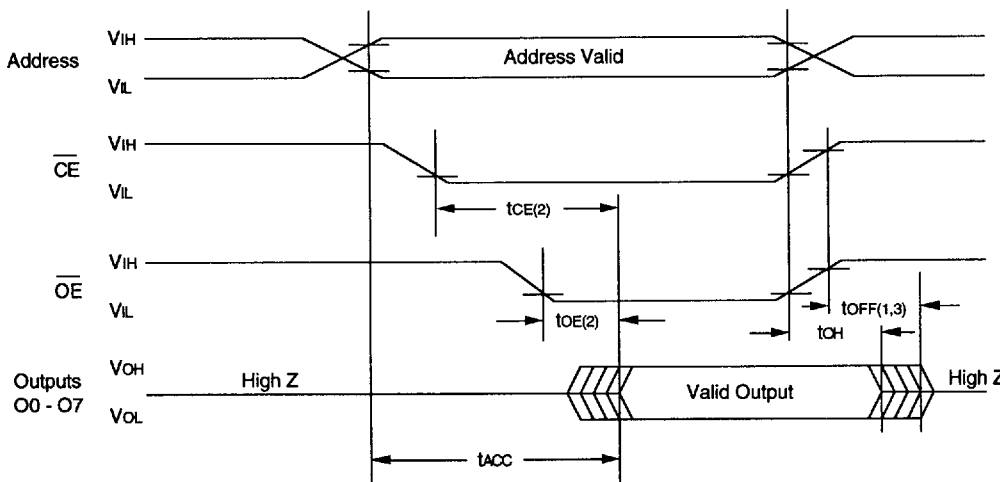
* Parts: C = Commercial Temperature Range; I, E = Industrial and Extended Temperature Ranges
Notes: (1) Active current increases 8 mA per MHz up to operating frequency for all temperature ranges.
(2) Vcc must be applied before VPP, and be removed simultaneously or after VPP.

**READ OPERATION
AC Characteristics**

AC Testing Waveform: $V_{IH} = 2.4V$ and $V_{IL} = 0.45V$; $V_{OH} = 2.0V$ $V_{OL} = 0.8V$
 Output Load: 1 TTL Load + 100 pF
 Input Rise and Fall Times: 10 ns
 Ambient Temperature: Commercial: $T_{amb} = 0^{\circ}C$ to $70^{\circ}C$
 Industrial: $T_{amb} = -40^{\circ}C$ to $85^{\circ}C$
 Extended (Automotive): $T_{amb} = -40^{\circ}C$ to $125^{\circ}C$

Parameter	Sym	27C64-12		27C64-15		27C64-17		27C64-20		27C64-25		Units	Conditions
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max		
Address to Output Delay	t_{ACC}	—	120	—	150	—	170	—	200	—	250	ns	$\overline{CE} = \overline{OE} = V_{IL}$
\overline{CE} to Output Delay	t_{CE}	—	120	—	150	—	170	—	200	—	250	ns	$\overline{OE} = V_{IL}$
\overline{OE} to Output Delay	t_{OE}	—	65	—	70	—	70	—	75	—	100	ns	$\overline{CE} = V_{IL}$
\overline{CE} or \overline{OE} to O/P High Impedance	t_{OFF}	0	50	0	50	0	50	0	55	0	60	ns	
Output Hold from Address \overline{CE} or \overline{OE} , whichever occurs first	t_{OH}	0	—	0	—	0	—	0	—	0	—	ns	

READ WAVEFORMS



- Notes: (1) t_{OFF} is specified for \overline{OE} or \overline{CE} , whichever occurs first
 (2) \overline{OE} may be delayed up to $t_{CE} - t_{OE}$ after the falling edge of \overline{CE} without impact on t_{CE}
 (3) This parameter is sampled and is not 100% tested.

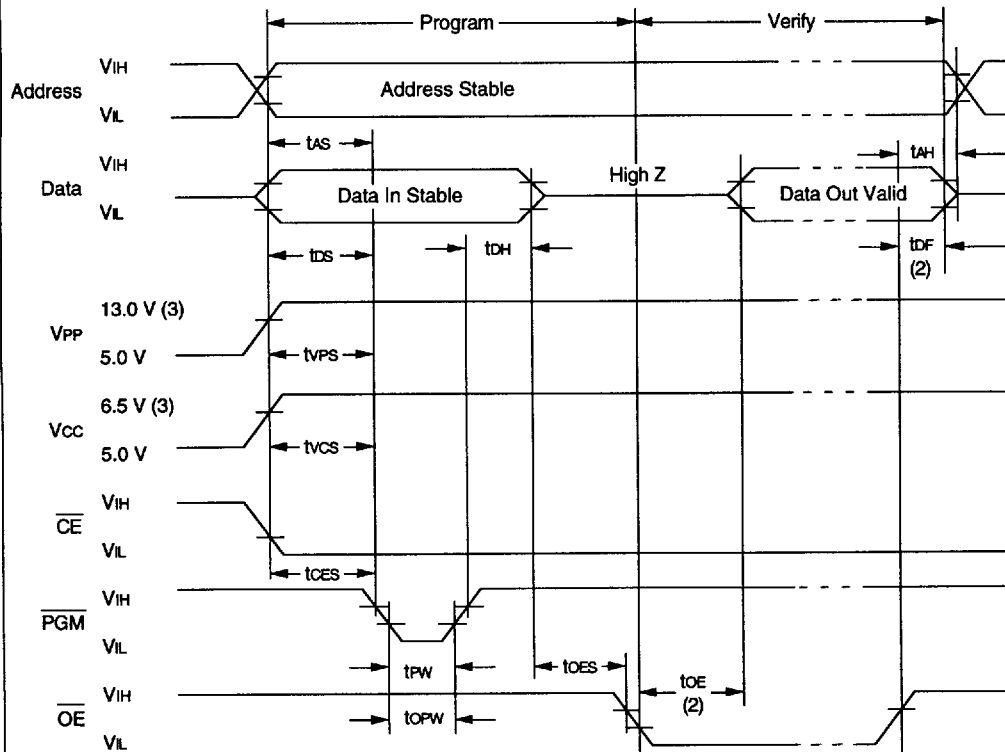
PROGRAMMING DC Characteristics		Ambient Temperature: $T_{amb} = 25^{\circ}\text{C} \pm 5^{\circ}\text{C}$ $V_{CC} = 6.5\text{V} \pm 0.25\text{V}$, $V_{PP} = V_H = 13.0\text{V} \pm 0.25\text{V}$				
Parameter	Status	Symbol	Min	Max	Units	Conditions
Input Voltages	Logic "1" Logic "0"	V_{IH} V_{IL}	2.0 -0.1	$V_{CC}+1$ 0.8	V V	
Input Leakage	—	I_{IU}	-10	10	μA	$V_{IN} = 0\text{V to } V_{CC}$
Output Voltages	Logic "1" Logic "0"	V_{OH} V_{OL}	2.4 —	— 0.45	V V	$I_{OH} = -400 \mu\text{A}$ $I_{OL} = 2.1 \text{ mA}$
V _{CC} Current, program & verify	—	I_{CC2}	—	20	mA	Note 1
V _{PP} Current, program	—	I_{PP2}	—	25	mA	Note 1
A9 Product Identification	—	V_H	11.5	12.5	V	

Note: (1) V_{CC} must be applied simultaneously or before V_{PP} and removed simultaneously or after V_{PP}

PROGRAMMING AC Characteristics		AC Testing Waveform: $V_{IH} = 2.4\text{V}$ and $V_{IL} = 0.45\text{V}$; $V_{OH} = 2.0\text{V}$; $V_{OL} = 0.8\text{V}$ Ambient Temperature: $T_{amb} = 25^{\circ}\text{C} \pm 5^{\circ}\text{C}$ $V_{CC} = 6.5\text{V} \pm 0.25\text{V}$, $V_{PP} = V_H = 13.0\text{V} \pm 0.25\text{V}$				
for Program, Program Verify and Program Inhibit Modes		Symbol	Min	Max	Units	Remarks
Address Set-Up Time		t_{AS}	2	—	μs	
Data Set-Up Time		t_{DS}	2	—	μs	
Data Hold Time		t_{DH}	2	—	μs	
Address Hold Time		t_{AH}	0	—	μs	
Float Delay (2)		t_{DF}	0	130	ns	
V _{CC} Set-Up Time		t_{VCS}	2	—	μs	
Program Pulse Width (1)		t_{PW}	95	105	μs	100 μs typical
$\overline{\text{CE}}$ Set-Up Time		t_{CES}	2	—	μs	
$\overline{\text{OE}}$ Set-Up Time		t_{OES}	2	—	μs	
V _{PP} Set-Up Time		t_{VPS}	2	—	μs	
Data Valid from $\overline{\text{OE}}$		t_{OE}	—	100	ns	

Notes: (1) For express algorithm, initial programming width tolerance is 100 $\mu\text{s} \pm 5\%$.
(2) This parameter is only sampled and not 100% tested. Output float is defined as the point where data is no longer driven (see timing diagram).

PROGRAMMING
Waveforms (1)



- Notes: (1) The input timing reference is 0.8 V for V_{IL} and 2.0 V for V_{IH}.
 (2) t_{DF} and t_{OE} are characteristics of the device but must be accommodated by the programmer.
 (3) V_{CC} = 6.5 V ± 0.25 V, V_{PP} = V_H = 13.0 V ± 0.25 V for Express algorithm.

MODES

Operation Mode	\overline{CE}	\overline{OE}	PGM	V _{PP}	A ₉	O ₀ - O ₇
Read	V _{IL}	V _{IL}	V _{IH}	V _{CC}	X	DOUT
Program	V _{IL}	V _{IH}	V _{IL}	V _H	X	DIN
Program Verify	V _{IL}	V _{IL}	V _{IH}	V _H	X	DOUT
Program Inhibit	V _{IH}	X	X	V _H	X	High Z
Standby	V _{IH}	X	X	V _{CC}	X	High Z
Output Disable	V _{IL}	V _{IH}	V _{IH}	V _{CC}	X	High Z
Identity	V _{IL}	V _{IL}	V _{IH}	V _{CC}	V _H	Identity Code

X = Don't Care

Read Mode

(See Timing Diagrams and AC Characteristics)

Read Mode is accessed when

- the \overline{CE} pin is low to power up (enable) the chip
- the \overline{OE} pin is low to gate the data to the output pins.

For Read operations, if the addresses are stable, the address access time (t_{ACC}) is equal to the delay from \overline{CE} to output (t_{CE}). Data is transferred to the output after a delay from the falling edge of OE (t_{OE}).

Standby Mode

The standby mode is defined when the \overline{CE} pin is high (V_{IH}) and a program mode is not defined.

When these conditions are met, the supply current will drop from 20 mA to 100 μ A.

Output Enable

This feature eliminates bus contention in microprocessor-based systems in which multiple devices may drive the bus. The outputs go into a high impedance state when the following condition is true:

- The \overline{OE} and \overline{PGM} pins are both high.

Erase Mode (U.V. Windowed Versions)

Windowed products offer the capability to erase the memory array. The memory matrix is erased to the all 1's state when exposed to ultraviolet light. To ensure complete erasure, a dose of 15 watt-second/cm² is required. This means that the device window must be placed within one inch and directly underneath an ultraviolet lamp with a wavelength of 2537 Angstroms, intensity of 12,000 μ W/cm² for approximately 20 minutes.

Programming Mode

The Express Algorithm has been developed to improve the programming throughput times in a production environment. Up to ten 100-microsecond pulses are applied until the byte is verified. No overprogramming is required. A flowchart of the express algorithm is shown in Figure 1.

Programming takes place when:

- VCC is brought to the proper voltage,
- VPP is brought to the proper V_H level,
- the \overline{CE} pin is low,
- the \overline{OE} pin is high, and
- the \overline{PGM} pin is low.

Since the erased state is "1" in the array, programming of "0" is required. The address to be programmed is set via pins A0-A12 and the data to be programmed is presented to pins O0-O7. When data and address are stable, \overline{OE} is high, \overline{CE} is low and a low-going pulse on the PGM line programs that location.

Verify

After the array has been programmed it must be verified to ensure all the bits have been correctly programmed. This mode is entered when all the following conditions are met:

- VCC is at the proper level,
- VPP is at the proper V_H level,
- the \overline{CE} line is low,
- the PGM line is high, and
- the \overline{OE} line is low.

Inhibit

When programming multiple devices in parallel with different data, only \overline{CE} or \overline{PGM} need be under separate control to each device. By pulsing the CE or PGM line low on a particular device in conjunction with the PGM or CE line low, that device will be programmed; all other devices with CE or PGM held high will not be programmed with the data, although address and data will be available on their input pins (i.e., when a high level is present on CE or PGM); and the device is inhibited from programming.

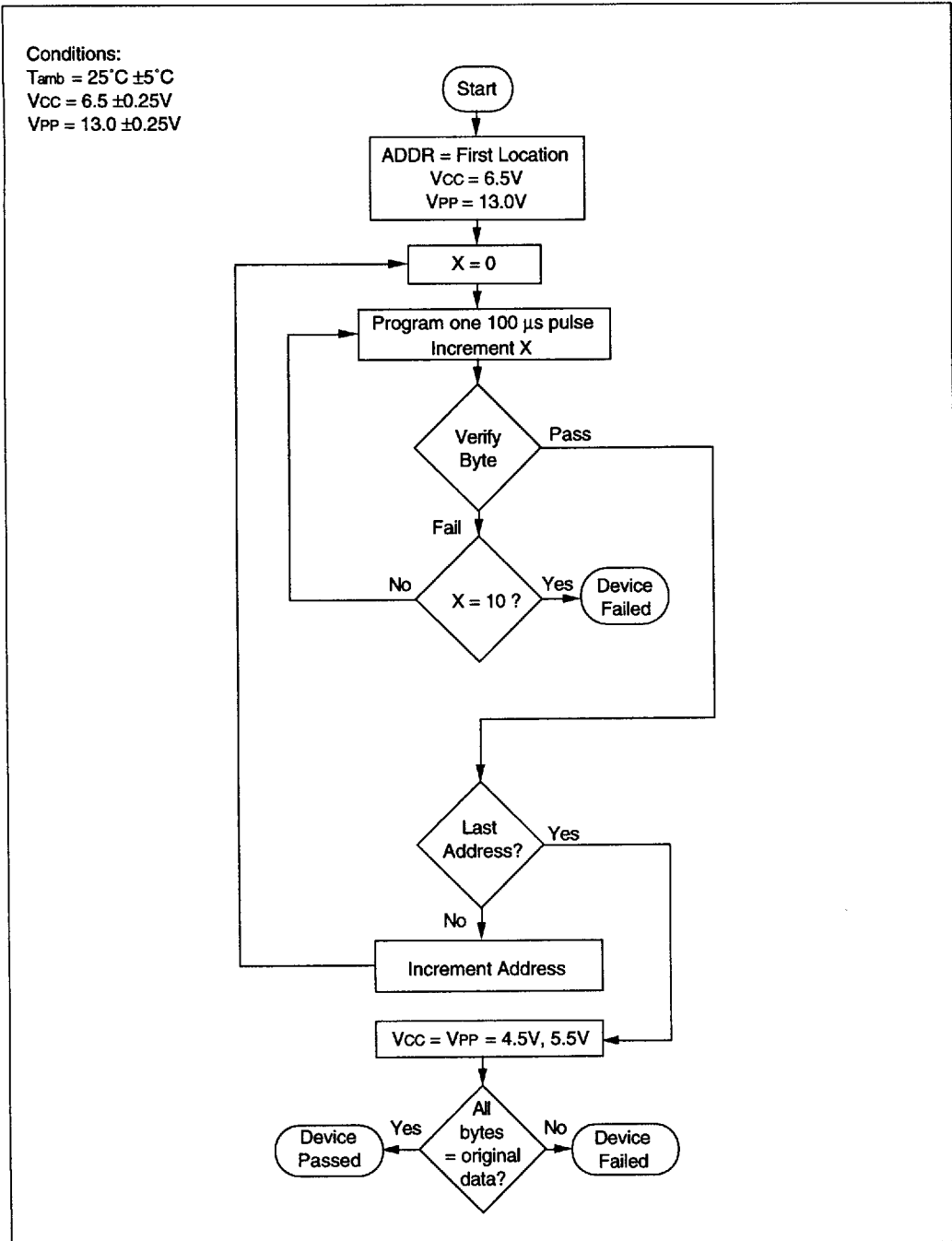
Identity Mode

In this mode specific data is output which identifies the manufacturer as Microchip Technology Inc. and device type. This mode is entered when Pin A9 is taken to V_H (11.5V to 12.5V). The \overline{CE} and \overline{OE} lines must be at V_{IL} . A0 is used to access any of the two non-erasable bytes whose data appears on O0 through O7.

Pin \rightarrow	Input	Output								
Identity \downarrow	A0	O7	O6	O5	O4	O3	O2	O1	O0	Hex
Manufacturer	V_{IL}	0	0	1	0	1	0	0	1	29
Device Type*	V_{IH}	0	0	0	0	0	0	1	0	02

* Code subject to change.

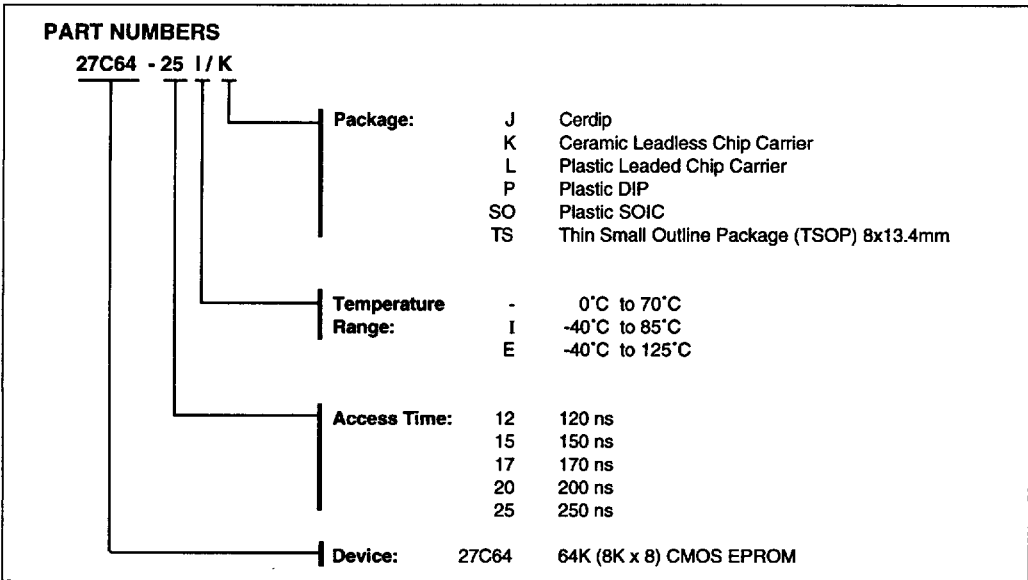
FIGURE 1 - PROGRAMMING EXPRESS ALGORITHM



27C64

SALES AND SUPPORT

To order or to obtain information, e.g., on pricing or delivery, please use the listed part numbers, and refer to the factory or the listed sales offices.





MICROCHIP

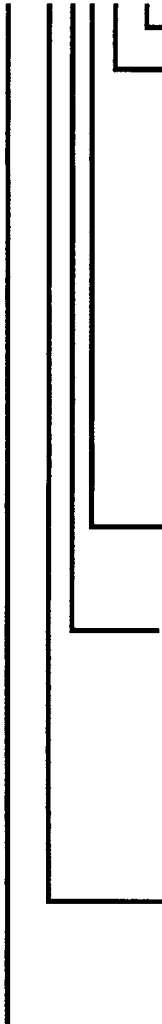
PACKAGING

Commercial/Industrial Outlines and Parameters

COMMERCIAL AND INDUSTRIAL PARTS

Part Number Suffix Designations:

XXXXXXXXXX - XX X / X X XXX



ROM Code or Special Requirements

Case Outline

- D = Ceramic
- J = Cerdip (with window if EPROM) - all product except Microcontrollers
- K = LCC (Ceramic Leadless Chip Carrier, not thermally enhanced)
- L = PLCC (Plastic Leaded Chip Carrier)
- P = Plastic
- S = Die in Waffle Pack
- W = Die in Wafer Form
- CB = COB (Chip-On-Board)
- JN = Cerdip, no window - for Microcontrollers only
- JW = Cerdip, windowed - for Microcontrollers only
- PQ = PQFP
- SJ = Skinny Cerdip
- SL = 14-Lead Small Outline .150 mil
- SM = Small Outline .207 mil
- SN = Small Outline .150 mil
- SO = Small Outline .300 mil
- SP = Skinny Plastic Carrier
- SS = Shrink Small Outline Package
- TS = Thin Small Outline (TSOP) 8mm x 20mm
- VS = Very Small Outline (VSOP) 8 x 13mm

Process Temperature

- Blank = 0°C to +70°C
- I = -40°C to +85°C
- E = -40°C to +125°C

Speed

(EPROM / High Density EEPROM)

- 55 = 55 ns
- 70 = 70 ns
- 90 = 90 ns
- 10 = 100 ns
- 12 = 120 ns
- 15 = 150 ns
- 17 = 170 ns
- 20 = 200 ns
- 25 = 250 ns

Frequency

- Blank = 20.5 MHz
- 14 = 14.4 MHz
- 25 = 25.6 MHz
- 32 = 32.8 MHz

Crystal Frequency Designator for PIC16/17 Microcontrollers

- LP = 4 μ s - Low Power
- RC = 2 μ s - Resistor Capacitor
- XT = 1 μ s - Crystal
- HS = 20 MHz - High Speed Crystal
- 10 = 10 MHz - High Speed Crystal
- 04 = 4 MHz - Crystal or RC
- 16 = 16 MHz - High Speed Crystal
- 20 = 20 MHz - High Speed Crystal
- 25 = 25 MHz - High Speed Crystal

OPTION

- = t_{wc} = 1 ms
- F = t_{wc} = 200 μ s
- X = Rotated pinout
- T = Tape and Reel

Device Type (Up To 10 Digits)

- C = Indicates CMOS
- LC = Indicates Low Power CMOS
- AA = 1.8V
- LV = Low Voltage
- HC = High Speed
- LCS = Low Power Security

Examples:

27C256T-15I/J
PIC16C54-RC/ISO



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- 16-Lead, Side Brazed, 300 mil 11-1-4
- 18-Lead, Side Brazed, 300 mil 11-1-5
- 22-Lead, Side Brazed, 400 mil 11-1-6
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16-Lead, 300 mil	11-2-4
18-Lead, 300 mil	11-2-5
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24-Lead, 300 mil	11-2-8
28-Lead, 300 mil	11-2-9
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40-Lead, 600 mil	11-2-11
48-Lead, 600 mil	11-2-12

B. Plastic Leaded Chip Carrier (Surface Mount, "L" Case Outlines)

Symbol List for Plastic Leaded Chip Carrier Package Parameters	11-2-13
28-Lead (Square)	11-2-14
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44-Lead (Square)	11-2-16
68-Lead (Square)	11-2-17
84-Lead (Square)	11-2-18

C. Plastic Small Outline (SOIC) (Surface Mount, "SN, SL, SM, SW, SO" Case Outlines)

Symbol List for Plastic Small Outline Package Parameters	11-2-19
8-Lead, 150 mil (Body)	11-2-20
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14-Lead, 150 mil (Body)	11-2-22
18-Lead, 300 mil (Body)	11-2-23
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D. Plastic Shrink Small Outline (SSOP) (Surface Mount "SS" Case Outlines)

Symbol List for Plastic Shrink Small Outline Package Parameters	11-2-27
20-Lead, 209 mil Body (5.30mm)	11-2-28
28-Lead, 209 mil Body (5.30mm)	11-2-29

E. Plastic Thin Small Outline (TSOP) and Very Small Outline (VSOP) (Surface Mount, "TS" and "VS" Case Outlines)

Symbol List for Thin and Very Small Outline Package Parameters	11-2-30
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F. Plastic Metric Quad Flatpack (MQFP) (Surface Mount, "PQ" Case Outlines)

Symbol List for Plastic Metric Quad Flatpack Package Parameters	11-2-33
44-Lead, (10x10mm) Body 1.6/0.15mm	11-2-34